## SiPM Applications past and future at FNAL or what's been done so far and what we still hope to do

G. Pauletta for the **FACTOR** collaboration

Outline

Background What's been done Future plans

## **Motivations**

The FACTOR collaboration interested in the development of the device and in its optimization for application to HEP:

#### **Present interests focus on:**

- Calorimetry with fiber-based optical readout
- Large area scintillator based muon counters
- future space experiments for detection of UHECR

#### **Action Plan:**

- comparative studies for detailed understanding of device characteristics
- Application tests
- Optimization of properties as a function of application
- definition of readout parameters and electronics

## History

- 2005 -- FBK & INFN fund SiPM development
- 2006 -- first batch (1mmx1mm) IRST devices available test of these SiPMs for large - area muon counters at FNAL TB (Exp. T956)
   --- FACTOR Proposed and funded (beginning 2007)
- 2006/2007
  - -- plans for new SiPM equipped plane for T956
  - -- FBK (IRST) developes SiPMs for this plane (custom geometry and improved fill factor)
  - -- FNAL (Rubinov) starts developing f.e. electronics for T.B.
  - --SiPM test facility developed at SiDet (Adam)
  - -- systematic SiPM character. starts up a Ts/UD FBK devices include trenches and gettering
- 2008 -- irradiation tests at Ts/Ud (FACTOR)
   -- dual readout calorimetry an option for SID

## T956:LC Scintillator-based Muon/Tail-catcher R&D

Hodoscopes of polystyrene scintillator bars\*. Light collected by single 1.2mm wls fiber readout by MAPMT



## Four Detector planes

### Single ended readout

#### Dual readout



## ILC Muon/Tail CatcherTest Setup



Scintillator-strip planes installed in Fermilab Beam Test Facility

Planes: 1.25m X 2.5m

256 scintillator strips: 4.1cm (W) X 1cm (T) X 1.8m (L). Two planes have single- ended readout and 2 planes have both ends of strips readout.

Read out by 384 PMT channels



## Beam Operating conditions

- DAQ triggered on beam; no strips in the trigger.
- When prime user, we had low intensity, ~ 1000p/sec during spill, two 1-sec spills/minute, 12 hours/day.
- When secondary user we operated up to ~20K p/sec.
- DAQ data rate limited < 50Hz. (CAMAC readout)
- Beam spot at +120 GeV/c ~ 1 cm FWHM.
- Additional beam particles within ADC gate (170ns) ~10% of time, even at low rates.
- Offline veto of multiple beam particles using beam counter.

## Beam Test Objectives

- Pulse height characteristics
- Measurement of integrated dE/dx charge => N<sub>p.e.</sub>
- Strip longitudinal position response.
- Strip-to-strip response.
- Read out two ends or only one end?
- SiPM confirmation data w/similar strips.

## Baseline SiPMs used for T956



SiPM structure: - 25x25 cells

- microcell size: 40x40mm<sup>2</sup>

Geometry of baseline model NOT optimized formaximum PDE (fill factor ~20%).



Standard calorimeter – type readout:

- digitize signal in ADC gate
- no waveform digitization



## Preliminary bench tests with pulsed light source



An example of the integrated charge distribution from a weak light source illuminating a SiPM at -35V, accumulated using an ADC with 0.25 pC /channel is shown alongside. From this distribution we deduce that the amplified signal corresponding to 1 photoelectron corresponds to  $\sim$  10 ADC channels, from which we calculate that the overall gain is about

$$\frac{10 \times 0.25.10^{-12} C}{1.6 \times 10^{-19} C} = 1.6 \times 10^{7}$$



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Given an amplifier gain of ~10, that the SiPM gain is ~1,6.10<sup>6</sup> for a Bias voltage of -35V. This value is very close to the expected value given by IRST specifications illustrated below

dark count vs. bias

Single thermal photoelectron rates were also found to be consistent with specifications



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Using the same readout circuits and fittings used for the preliminary tests, SiPMs were then mounted to the two ends of a scintillation counter and aligned with the ends of the wavelength-shifting (wls) fiber used to collect and transport the light generated in the scintillator. The counter is illustrated below:



The SiPMs were alligned, by means of an improvised fitting with the ends of the wls fiber, which were polished at both ends at lab 7 prior to cementing the fiber in the groove. The sentive surface of the SiPM was maintained at a distance of ~ 0.5. mm from the polished fiber face. Because the active area of the SiPMs (1 mm<sup>2</sup>) is equal to that of the fiber end, alignment is critical

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Alignment was optimized by detecting cosmic muons in a light – tight box . Signals corresponding to the passage of charged cosmics, triggered by the conicidence of two trigger counters of width equal to that of the scintillator bar, were used to align the SiPm with the fiber end as shown below.



counter was then transported to the MT6 test beam and installed in front of the muon counter array of T956



. The T956 muon counters are mounted on s support structure which allows for both horizontal and vertical ( remotely controlled ) motion.. The DAQ trigger include 2 Trigger counters just upstream of our counter array which define a 1cm<sup>2</sup> effective beam spot at the position of our counter.

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Data was taken with both 120 GeV and 60 GeV protons. The signal currents were integrated over gate intervals of 160 ns in ADCs having a sensitivity of 0.25 pC / channel.. Examples of distributions from the West end of the counter are shown below for different bias and amplifier settings.



Inefficiency goes from 8% to less than 1% as the bias is raised from 35V to 36V. At the same time, the mean number of photoelectrons per mip goes from 4.6 to 6.5

Pedestal runs were taken in the absence of beam with a free – running pulser substituting the beam trigger (see figures above) These runs also allowed for the measurement accidentals due to the relatively high thermal dark current typical of these devices. The go from ~10% to ~ 20%. Given the ADC gate width of 160 ns, this corresponds to thermal single p.e. dark currents of about 1 - 1.5 MHz

# Preliminary study of Scint. Strip viewed by IRST SiPM at the FNAL test beam





Data with 120 Gev proton - beam

$$N_{p.e.} \approx 6.5 p.e.$$
  
 $\varepsilon = 99\%$   
 $N_{d.c.} \approx 1.5 MHz$   
 $G \approx 1.6 \times 10^6$ 

a: TPDPPC, Trieste

Future plans for the muon/Tailcatcher at FNAL:

- •SiPMs are our future interest
- Begin by instrumenting a full plane with SiPMs (100 Custom SiPMs produced by FBK IRST for the purpouse)
- •Bench Tests of Russian, IRST, MPPC and other avalanche photo-diodes have started at Fermilab and are ongoing at NIU and Trieste/Udine.
- •Electronics development in concert with DHCal are in the

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50×50 um

C. Piemonte: June 13<sup>th</sup>, 2007, Perugia

F.E. Electronics development a t FNAL



Paul Rubinov



### ... Plans for Calorimetry?

- \* CALICE (PFA) is already taking data at FNAL TB
- Dual readout has now been recognized as a possible alternative for SID
- Looks like a total absorption calorimeter with transverse segmentation is the way to go crystals? which?
   see Adam's talk
- Finer transverse segmentation (PFA?) could be obtained by alternating crystals with Si -detector planes. This would also introduce a measure of longitudinal segmentation.
- Adam is actively investigating crystal tecnology --
- Need to get going going but available funds insufficient -- proposals submitted both in US and Italy

### Meantime!

- Simulate --- Adam and collaborators already up and running
- Study light collection schemes --- don't need a full-fledged calorimeter module for that
- Develop SiPMs with extended sensitivity in the blue side of the spectrum (has FBK IRST given up on that?)
- Start developing readout electronics
- •.....and continue with SiPM studies

#### Si-detector Clean room at UD





Dotazioni				
Object	producer	#		
1-side probestation	Maehlum	1		
Probe arms	Karl Suss	3		
1-kV probe arm	Karl Suss	2		
2-side probe chuck	U. Dortmund	1		
X-Y+Z table + controller	Micos	1		
LCR meter 4284A	HP	1		
HV source/measure unit 237	Keithley	1		
Electrometer 6514	Keithley	1		
Picoammeter/voltage source 487	Keithley	1		

\* detector development lab with
\*3 GHz LeCroy sampling scope
\*NIM/CAMAC/VME DAQ electronics
\*keithly powe-supplies/pA
\*~1ns pulse N-laser
\*100 ps pulsed diode-laser
\*calibrated detectors
\*optical bench



Vbd (V)

32,5

33,0

Ibd (nA)

3,6

3,6

Rapid check functionality & uniformity Sensitive to principal characteristics

dark current  $I_{dc} = I_{tot} - I_{leak}$ is prop. to gain G and dark count (DC) $I_{dc} \propto G.(DC)$  $G \propto V$ ,  $DC \propto V$ and since  $I_{dc} \propto V^2$ IRST 1mm<sup>2</sup>

IRST-11	33,5	3,8	<b>IRST devices generally very uniform</b>
IRST-03	33,0 33,5	3,1	second batch

SiPM

**IRST-00** 

**IRST-02** 

## Static measurements-2



## Static measurements-3





SiPM	Vdep (V)	Cdep (pF)
IRST-00	21	54
IRST-02	21	55
IRST-03	21	55
IRST-08	21	55
IRST-11	21	54

$$\div 625 \approx 90 fF$$

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## **Device characterization**<sup>1,2</sup>

 Static measurents: IV measurements for rapid test of device properties, uniformity and stability

 Dynamic tests: Output signal characterization and stability using noise signals in the dark

- >Signal rise time and fall time
- ≻Gain
- >Dark count
- >Optical cross talk
- >Afterpulsing

### PhotoDetection Efficiency

1)All characterizations reported here are for 1mm<sup>2</sup> devices

2) for a thorough characterization of the first SiPM prototypes fabricated at ITC-irst see C. Piemonte, IEEE TNS, February 2007

Simplified Schematic







Amplifier used for fast characterization of SiPMs: Agilent ABA-52563 3.5 GHz RFIC Amplifier (economic, compact, internally 50- $\Omega$  matched, gain ~ 20 dB) Dimensions 1.8 x 1.8 mm2



Red trace: amplifier's output



MRS SiPMs have 2.5 to 50 times larger Rq values than IRST (polysilicon) devices  $\rightarrow$  longer recovery rimes

Dark count IRST\_A1



Dark count, Forimtech 1 mm<sup>2</sup>





IRST, Dark count (room T)



IRST\_A1



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IRST\_D1





## Temperature dependences - 3

#### IRST\_D1, Dark count



The following are static measurements performed at ITC-IRST and reported on at a recent (June 13<sup>th</sup> 2007) workshop at Perugia



C. Piemonte: June 13<sup>th</sup>, 2007, Perugia



## Gain & Dark count (uniformity)



#### Gain and Dark count measured on devices from the same wafer

C. Piemonte: June 13<sup>th</sup>, 2007, Perugia

## **Optical cross-talk**



1400

#### Short integration time ⇒ only single/double/....pulses are counted

Number of events with optical cross-talk increases with voltage

Cross-talk below 5% at 4V over-voltage.



### After-pulsing



## Photo-detection efficiency



C. Piemonte: June 13<sup>th</sup>, 2007, Perugia

### **Photodetection efficiency**



First signal and noise characteristics of the last devices

Noise and charge resolution





# Characterization of SiPMs (1 mm<sup>2</sup>from second batch) used for preliminary at Fnal test beam

Visual inspectons (SiDet) and dynamic tests at lab 6 prior to use of SiPMs in Test Beam yielded results compatible with IRST measurements:

$$V_{R} = 34.1 V$$

-34.5

-35.0

-35.5

ZO JUINE ZUUI

-36.0

Gains between  $\sim 1$  and  $2 \times 10^{6}$ 

dark count vs. bias

-36.5

Tensione (V)

-37.0

-37.5



#### Future work at fnal





Whole assembly mounted on movable (x,y) support

Scintillator strips :  $4 \text{cm} \times 1 \text{cm} \times (1 - 2 \text{ m})$ , read out by wis fiber. Groove for fiber extruded with scintillator



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## Tiles used for Ts/Ud tests

- Dubna scintillator + keyhole/double-spiral groove + 3M superreflector
- Kuraray fiber achieved 37 pe/MIP without optical glue, 44 pe/MIP with glue.
- Lose x3-4 along optical path to PMT (attenuation+splice+ connector)







#### Fiber application study: Fiber Arrays



- Fiber Array mapped via a <u>Template</u> on a16 channel multi-anode photomultiplier H6568
- A second <u>Fiber Array</u> equipped with <u>SiPM</u> (8 channels, each corresponding to 2 of the adjacent channels of MAPMT)

The 2 arrays are accurately superimposed and aligned in a PS test beam (T11)





#### **FACTOR**

# 3-year project (2007 – 2009) funded by INFN *Participants:*

INFN laboratories and/or universities at:Trieste, Udine, Messina *collaborating with* 

ITC (now Bruno Kessler Foundation) -IRST Trento, Italy

Background:

2005: INFN funds project (DASiPM) for the development of SiPM devices, mainly for PET application 2007: INFN funds continuation of DASIPM and expands development to other applications (FACTOR)

INFN-Trieste has a long – standing collaboration with IRST in the development of Silicon-based detectors for application in accelerator, underground and space – based experimental particle physics.

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## **Present IRST technology\***

\*C. Piemonte "A new Silicon Photomultiplier structure for blue light detection" NIMA 568 (2006)



#### Distinguishing characteristics:

Very shallow junction
 ARC optimized for short wavelenghts (~400nm)
 polysilicon quenching resistors

**Development History** 

Development started at the beginning of 2005

#### **Baseline geometry**

- SiPM structure:
- 25x25 cells
- microcell size: 40x40mm<sup>2</sup>

Development has continued over last two years: several succeeding production runs to to develop geometries for different applications



Geometry of baseline model NOT optimized formaximum PDE (fill factor ~20%).

and to optmize operational characteristics

## Principal characteristics of interest

- Gain
- Noise
   >dark count
   >afterpulsing
   >optical cross-talk
- PhotoDetection Efficiency (PDE)
- Dynamic Range
- Time characteristics
   >rise time, resolution, recovery time
- Radiation hardness
- Sensitivity to magnetic fiels

Other considerations

- Packaging
- •Readout electronics

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# backup slides

### Results on IRST devices: gaussian $\sigma_{t}$



Gianmaria Collazuol VCI 2007 Vienna 19-24 Feb 2007

## Tile test setup at Frascati





Erik Vallazza, Michela Prest

## **Development History**

### Development started at the beginning of 2005.

September 2005 First batch

May 2006 Second batch

#### October 2006 Third batch

May 2007 Fourth batch

- Establish functionality and base-line parameters
- Verify reproducibility of the first batch
- First attempt to reduce optical cross-talk
- First attempt to reduce dark count rate
- optimize fill factor
- new geometries for different applications
- continue the study on dark count reduction